

# **INITIAL PRODUCT/PROCESS CHANGE NOTIFICATION #16946**

Generic Copy

Issue Date: 09-Jan-2013

TITLE: Initial Notification of Qualification of OSPI for Test of 16 Lead TSSOP

**PROPOSED FIRST SHIP DATE:** 09-May-2013

AFFECTED CHANGE CATEGORY(S): ON Semiconductor Test Site

**ADDITIONAL RELIABILITY DATA: NA** 

### FOR ANY QUESTIONS CONCERNING THIS NOTIFICATION:

Contact your local ON Semiconductor Sales Office

## **NOTIFICATION TYPE:**

Initial Product/Process Change Notification (IPCN)

First change notification sent to customers. IPCNs are issued at least 120 days prior to implementation of the change. An IPCN is advance notification about an upcoming change and contains general information regarding the change details and devices affected. It also contains the preliminary reliability qualification plan.

The completed qualification and characterization data will be included in the Final Product/Process Change Notification (FPCN).

This IPCN notification will be followed by a Final Product/Process Change Notification (FPCN) at Least 90 days prior to implementation of the change.

## **DESCRIPTION AND PURPOSE:**

Initial Process Change Notice to notify customers of the transfer of the ON Semiconductor test location at Carmona, Philippines (OSPI) for 16 lead TSSOP package. The devices listed on this IPCN have historically been tested at the SPEL facility located in Chennai, India.

Issue Date: 09-Jan-2013 Rev. 01 Page 1 of 2

## **INITIAL PRODUCT/PROCESS CHANGE NOTIFICATION #16946**

**RELIABILITY DATA SUMMARY: N/A** 

**ELECTRICAL CHARACTERISTIC SUMMARY: N/A** 

#### **QUALIFICATION PLAN:**

Test validation Test: Cpk>1.33 GRnR: Cpk>1.33

# **List of affected General Parts:**

ASM3P2854CG-16TR

ASM3P2855DG-16TR

P1P2859AG-16TR

P1P2861AG-16TR

P3P623S00EG-16TR

P512308AF-216TT

P5P2308AF-1H16TR

P5P2308AF-216TR

P5P2308AF-3-16TR

P5P22309AF-1-16TR

P5P22309AF-1-16TT

P5P2309AF-1H16TR

PCS1P2860AG-16TR